Building and Testing Yield Curve Generators for P&C Insurance

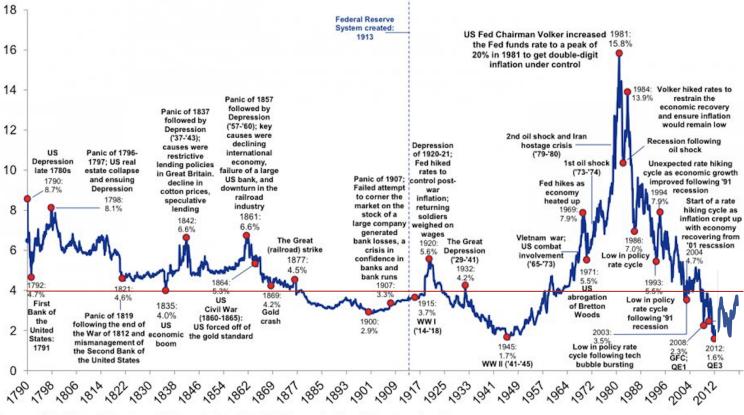
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Abstract Interest-rate risk is a key factor for property-casualty insurer capital. P&C companies tend to be highly leveraged, with bond holdings much greater than capital. For GAAP capital, bonds are marked to market but liabilities are not, so shifts in the yield curve can have a significant impact on capital. Yield-curve scenario generators are one approach to quantifying this risk. They produce many future simulated evolutions of the yield curve, which can be used to quantify the probabilities of bond-value changes that would result from various maturity-mix strategies. Some of these generators are provided as black-box models where the user gets only the projected scenarios. One focus of this paper is to provide methods for testing generated scenarios from such models by comparing to known distributional properties of yield curves.

Typically regulators, security analysts, and customers focus on one to three-year time frames for capital risk. This is much different than risk-management in other financial institutions, where the focus is on how much markets can move from one day's dose to the next day's opening. Those institutions trade continuously when the markets are open, and manage risk with derivatives. Rec insurers, on the other hand, hold bonds to maturity and manage cash-flow risk by matching asset and liability flows. Derivative pricing and stochastic volatility are of little concern over the relevant time frames. This requires different models and model testing than what is common in the broader financial markets.

To complicate things further, interest rates for the last decade have not been following the patterns established in the sixty years following WWII. We are now coming out of the period of very low rates, yet are still not returning to what had been thought of as normal before that. Modeling and model testing are in an evolving state while new patterns emerge.

Our analysis starts with a review of the literature on interest-rate model testing, with a P&C focus, and an update of the tests for current market behavior. We then discuss models, and use them to illustrate the fitting and testing methods. The testing discussion does not require the model-building section. We do try to make the modeling more accessible to actuarial modelers, compared to our source papers in the financial literature. Code for MCMC estimation is included at the CAS GitHub site. Model estimation is getting easier as the software advances, and interested actuaries, who often have a better feel for the application *Casualty Actuarial Society E-Forum, Winter 2021* 1



The long history of long (10-year US treasuries) yields

Source: Global Financial Database, Goldman Sachs Global ECS Research. Special thanks to Jose Ursua.

Figure 1: History of Ten Year US Bond Rates

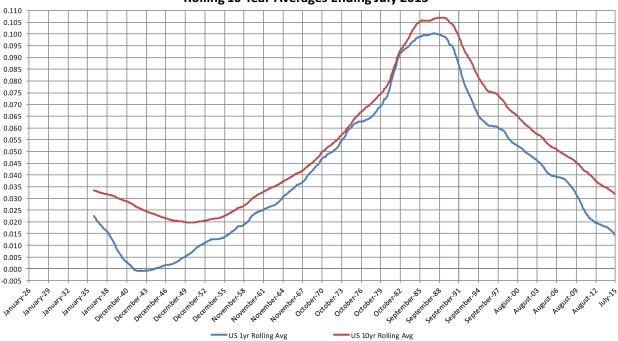
needs than do financial modelers, can use this to fit their own yield-curve generators.

Keywords: Economic scenario generators, affine models, interest rates, inflation, MCMC

1 A historical look

In this Section 1 we look at a long-term history of US interest rates for perspective. Section 2 reviews the literature on properties of yield curves for testing models, and updates the properties in the light of recent data. Section 3 introduces affine models, which often meet most of the yield-curve tests. In section 4 we fit some models. Section 5 then illustrates the tests by applying them to the fitted models. Appendix 1 covers some more general affine models, and Appendix 2 addresses fitting models by Markov-chain Monte Carlo (MCMC).

Figure 1 graphs long Treasury bond yields for 1790–2018. It is hard to identify a long-term equilibrium rate. Before the Civil War, the rate gravitated around 6%, but from 1870 to 1970, it was rarely above 4% – and it has returned to similar levels since about 2010. The postwar period of higher rates – say 1972 to 2007 – was considered the new normal at the



Rolling 10 Year Averages Ending July 2015

Figure 2: Ten-Year Rolling Average 1 and 10 Year Rates

time, and many economists who spent their careers in those years still consider it normal.

The longer history calls that normality into question. Some economists are now pointing out historical peculiarities of the postwar period. Piketty (2014) reports a few such findings. For instance, that period included a now-completed massive rebuilding of global assets, 50% of which, in monetary terms, were destroyed in the world wars. It was also a time of steadily increasing productivity, since diminished. Both of those elements boosted economic expansion, wages, and interest rates. Absent the postwar period, the current situation looks more like a continuation of the 1870–1970 levels than a return to 1990.

The graph also shows long periods of rising or falling rates. The rate generally declined for 39 years starting in 1861, then rose for 20 years, and then declined for 25 years, to 1.7% in 1945. Then it increased for 36 years, with some fluctuations, and dropped again for 31 years, getting to 1.8% in 2012.

Figures 2 and 3, from Pedersen et al. (2016), the SoA ESG report, show rolling average one and ten year rates and their standard deviations since 1936. The one-year rates are lower, but their standard deviations are higher, compared to the ten-year rates. The standard deviations loosely follow the rates. The Cox-Ingersoll-Ross (CIR) interest rate model assumes that for the shortest rates, the standard deviation is proportional to the rates. The gap between the

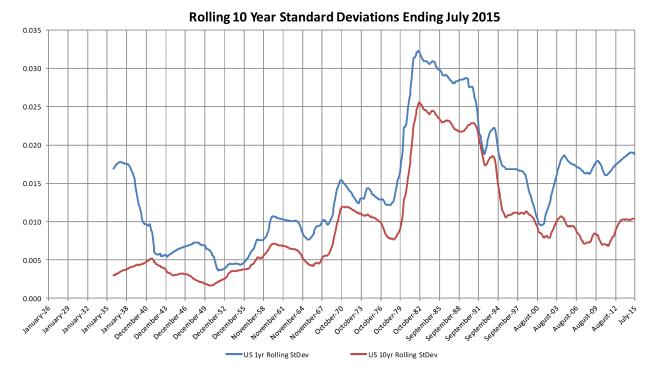


Figure 3: Ten-Year Rolling Average 1 and 10 Year Standard Deviations

one-year and ten-year rates was high in the early 1940s, much like it was recently. In the 1940s the one-year rates were even lower than they were in the 2010s and actually became negative for a few years.

2 Historical model tests and current updates

Several tests have been proposed for yield-curve models. We discuss proposed tests from three papers, and review these with recent data. The period from 2008 to 2018 had unusually low rates – comparable to those from 1938 to 1955. With the recent changes in economic conditions, it seems unlikely that such rates would return over the next several decades. But the historically unusually high rates from 1970 - 2000 had specific causes that also seem unlikely to repeat. This makes it difficult to select a relevant time period for measuring rate properties. What we do below is look at how the properties have been evolving over time in order to come up with reasonable criteria for model behavior. Many of the tests would be performed on scenarios simulated from the fitted models, but a few use fits to the data.

2a Tests from the Feldhűtter paper on fitting affine models

Feldhütter (2016) explores how well affine models fit historical properties of interest rates.

2a.1 Moments by maturity

Table 1 shows his exhibit of moments for US Treasury maturities of 1 – 5 years, using monthly

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Table 1: Moments of Treasury Yields								
maturity	1	2	3	4	5			
mean	5.60	5.81	5.98	6.11	6.19			
standard deviation	0.50	0.43	0.40	0.39	0.36			
skewness	0.83	0.79	0.78	0.77	0.77			
excess kurtosis	0.77	0.57	0.51	0.44	0.35			

observations from 1952:6 to 2004:12. This includes the unusually high rates of the 1970s and 80s. What it shows is mean rates that increase by maturity and volatilities that decrease. Higher moments are positive but small and also decline a bit by maturity.

The modestly positive higher moments in Table 1 have been challenging for models to match – most give much higher or virtually zero higher moments. If this holds up for more relevant data, it would be an important feature to capture for risk analysis.

The yield curve is usually upward sloping, and there are good reasons for that. Investors need higher yields to lock up their funds in longer rates, and to take a many-year risk of bond values going down due to rates increasing. The curve gets flat or inverted when the Federal Reserve raises short rates above the level at which the market is trading the longer obligations. This seems reasonably likely to happen over the next several years, so some curve inversions would be a good thing to see in a simulated scenario set.

Although shorter rates are normally more volatile than are longer rates, this pattern was reversed for six years beginning in August 2011. The short rates were too low to have much absolute volatility. As an alternative we looked at the volatility of the log of the rates.

Figure 4 shows 156-week moving standard deviations of rates and the log of rates from 1/2009 to 1/2019. Before August 2011 and after August 2017 the usual pattern held, with volatility decreasing as maturities increased. In between, the pattern was almost exactly reversed. The logs of the rates show more consistent volatilities. Except for a short period where rates longer than two years all had very little volatility, the usual pattern is maintained for those maturities. The one and two-year maturities always have higher log volatility than do the ten and longer year maturities, and drop below the three-to-seven-year log volatilities for only a relatively short period. Going forward it seems that the modeled volatilities of the logs of the rates should decline steadily with maturity. In the near term, it looks like the one-year log volatilities have stabilized around 0.6, while the others show a bit of an upward trend. Numbers a little higher than these would thus seem reasonable targets for model testing.

Figure 5 shows the skewness of the five-year rate over fairly long periods. It displays the rolling skewness of weekly rates over moving 500, 1000, and 1500 week periods, with the

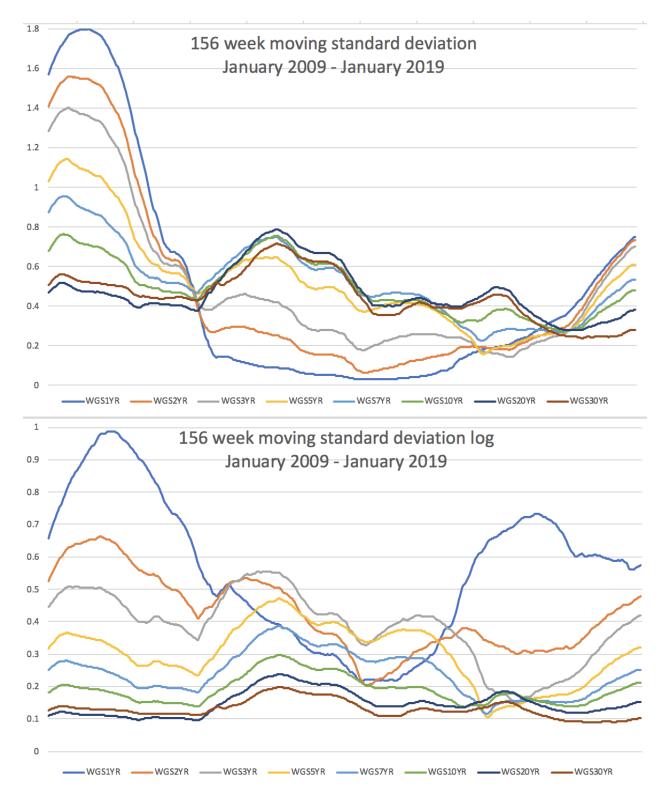


Figure 4: Three-Year Moving Standard Deviation of Rates and Log Rates by Maturity

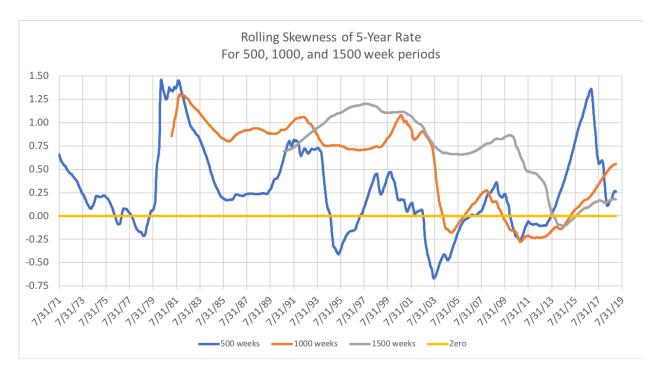


Figure 5: 500, 1000, and 100 Week Moving Skewness of Five-Year Rates

periods' ending points starting in 1971. These correspond roughly to 10, 20, and 30 year periods. The higher values in the earlier years appear to be due to the very high rates in the early 1980s. There is no consistent skewness that holds in general. There is a temporary spike due to the recovery from very low rates (below 1%) starting in 2016. These have since stabilized around 2.5%, so the spike seems to be over. For simulated rates going forward, very little skewness would be a good result – say below 0.25 but not too negative either.

2a.2 Volatility as related to levels of the rates

Feldhütter (2016) regresses the squared change in rates from month t to t+1 for each maturity against the level, slope, and curvature of the yield curve at month t. The level is the five-year rate, the slope is the difference between the five and one-year rates, and the curvature is the sum of the five and one-year rates less twice the three-year rate, respectively. This measure of curvature is higher when the midpoint of the curve is lower relative to the endpoints, so quantifies upward curvature. Table 2 shows the coefficients for each variable, along with their t-statistics, for each maturity.

The coefficients are small, as the squared change in rates is. The level coefficients all have quite significant t-statistics, showing that the volatility of rates is higher when the level of rates is. This effect is greatest for the shorter maturities, since the volatilities are higher for them. The other coefficients are not individually significant, but the slope coefficients display Building and Testing Yield Curve Generators for P&C Insurance

Table 2:	Volatili	ty Regr	ression	Coeffici	ents
maturity	1	2	3	4	5
level	0.11	0.07	0.06	0.05	0.04
t-statistic	-5.4	-5.4	-5.5	-6.9	-7.6
slope	-0.14	-0.08	-0.03	-0.02	0.02
t-statistic	1.5	1.2	0.7	0.5	-0.5
curvature	0.27	0.11	0.17	0.08	0.13
t-statistic	-1.4	-0.8	-1.7	-1.0	-2.1

a clear pattern of lower volatility for the shorter maturities for steeper yield curves. Volatility is also consistently but not significantly higher with less downward curvature.

However, the previous results no longer hold up. Test found that these coefficients were no longer significant, and sometimes had changed sign. The very low rates did not act in accord with the earlier results. This does not appear to be a useful test at this time, but should be reviewed as new data emerges.

2a.3 Annual rate changes by maturity related to curve slope

The value of a bond would generally go up over time as its time to maturity shortens. These changes have been found historically to be stronger (bigger value increase, bigger yield drop) when the current yield spread over the shortest yield is higher. Feldhütter (2016) does a regression for this effect, following the methodology of Campbell and Shiller (1991). With yield Y(t, n) at time t and time to maturity n, he finds the factors for a regression on the change in yield. That is, he estimates:

$$Y(t+1, n-1) - Y(t, n) = const + factor_n \frac{Y(t, n) - Y(t, 1)}{n-1} + res$$

The factors, shown in Table 3, are negative, which means that the drops in yield are greater when the spread over the one-year yield is higher, and are increasingly so as the maturity increases. This is a sort of mean reversion that investors would be looking for. A longer bond that has a particularly high spread relative to the shortest bond would be expected to increase more in value during the next year. Campbell and Shiller (1991) called this the excess-profits effect. Apparently the higher spread led later to a greater decrease in the longer rate. This seems counter-intuitive, as short rates are more volatile, so the wider spread would be expected to narrow due to an increase in the short rate, not a decrease in the long rate. Feldhütter (2016) also finds this effect suspect, but confirms it empirically.

Our Federal Reserve data does not have 4, 6, 8, or 9 year rates, so to update the analysis we looked at the change over two years for bonds that started as 5 or 7 years, and the change

	Table 3:	Yield Change	Regression	
	maturity	2 3	4	5
	factor	-0.78 -1.13	-1.52 -1.4	9
	t-statistic	1.4 1.8	2.2 -2.	0
	Table 4: Yie	eld Change Slo	opes by Peri	od
Period	4/53-12/78	1/84-12/08	1/09-1/19	4/53 - 1/19
2Y	-4.81	-0.36	-1.73	-0.93
3Y	-4.63	-0.34	-2.54	-1.18
5Y	0.91	0.76	-3.46	-0.54
7Y	1.18	0.65	-5.02	-0.66
10Y	1.86	1.39	-4.43	-0.25

over three years for the 10 year bonds. Preliminary analysis suggested that the very high rates around 1981 were distorting the results, but the very low rates of the last ten years were also unique. For this reason, we did regressions over 4 periods: the first 25 years in our data, from mid-1953 to 1978, the 25 years from 1984 through 2008 (thus skipping 1978–1984), 2009 – 2019, and the entire 66 years. Table 4 shows the results.

The entire period shows all negative slopes, but generally getting less negative by maturity. The two 25-year older periods show negative slopes for the 2 and 3-year rates, with increasingly positive slopes for the longer rates. Only the 10 recent years display the pattern found in earlier studies.

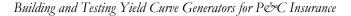
The past decade has featured very low short rates, with very low volatility. Thus in this period, a high spread over the 1-year rate would indicate a higher long rate. Then for it to decrease is just a form of mean reversion. The first two columns were 25-year periods of either generally increasing or generally decreasing rates, but their coefficients are similar. It could be that in those periods, higher spreads occurred during expansionary times, where overall rates were increasing more, or decreasing less, than when spreads were lower.

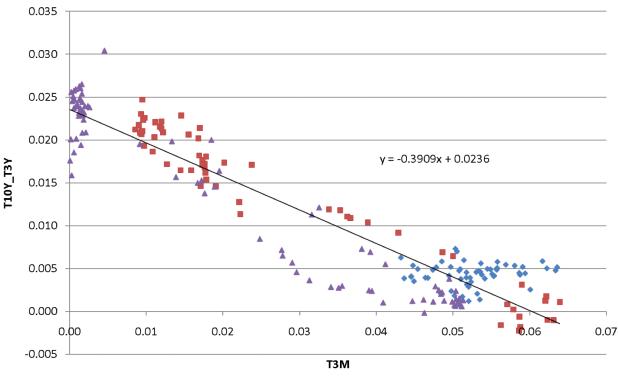
To test simulated rates going forward, negative coefficients would be reasonable for 2 and 3 year rates. For longer rates, right now any result could look plausible – positive, negative, or not significant coefficients. In the future, another look at the regressions would be called for.

2b Test from the Venter (2004) paper on ESGs for P&C companies

2b.1 Yield spreads and the short rate

This paper presents a test of yield curve scenarios based on the way longer yield spreads relate to the short rate. Since longer rates are less volatile, they go up less when the short rate increases. Thus the spread, say between the three and ten-year rates, would be expected





◆ 01/1995-12/1999 ■ 01/2000-12/2004 ▲ 01/2005-11/2011

Figure 6: Three-Year to Ten-Year Spreads as a Function of the Three-Month Rate

to decrease when the short rate increases, and widen again when it goes back down. Figure 6 shows data on this from 1995 to 2011 with a regression fit. The scatter around the regression line is fairly consistent for three sub-periods shown.

Figure 7 graphs the 3-year – 30-year spread as a function of the 1-year rate for two periods – 13 years starting in 2006, and about $3^{1}/_{2}$ years ending 1/4/19, both with fitted lines. The longer range shows two distinct periods, with similar slopes but different intercepts. The second of these periods is what is fit in the bottom panel. The graphs are similar to Figure 6, which shows the 3-10 spread for 1995-2001, so the general long-term pattern has been continuing. The slope in the upper panel is -0.53, compared to -0.67 in the lower panel. The standard deviation around the slope for the longer period is 0.57, but it is clearly less than this for the two sub-periods. It is 0.12 for the later period.

To use this as a test for simulated scenarios, fitting the trend line would be the starting point, then graphing the data and fitted line. An eyeball test of the overall look of the graph compared to Figures 6 and 7 would be a check of the basic pattern. For the near future, a slope similar to the recent period would be expected. For a longer projection, any slope less than -0.5 would seem reasonable. A flatter line would indicate that the longer spreads do

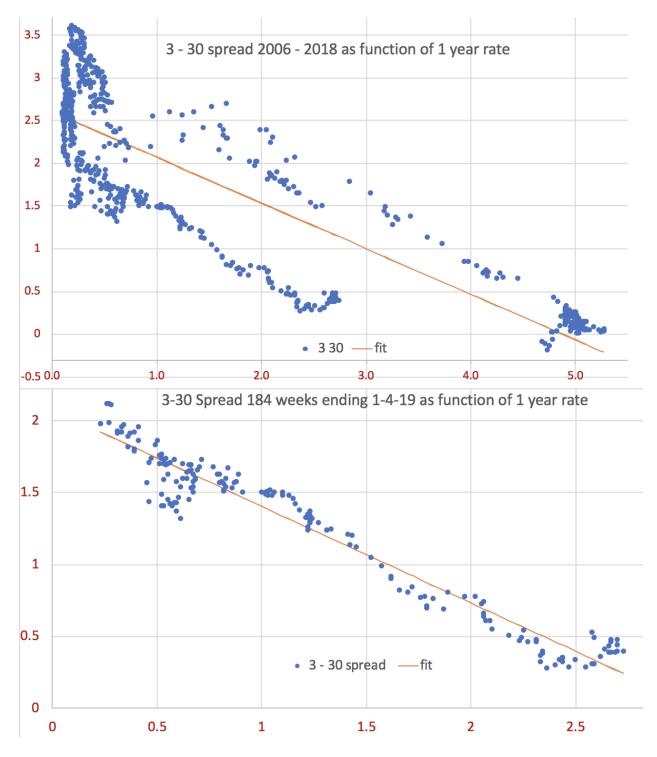


Figure 7: 3 - 30 Year Spread as Function of 1-Year Rates

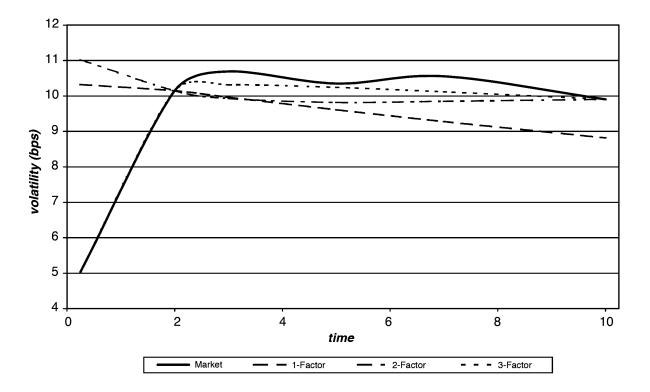


Figure 8: Actual and Implied Volatilites by Maturity for each Model

not compress much with increasing shorter rates, which could arise from problems in the volatilities. For a short-term projection, the spread around the line should be fairly small – below 0.2 perhaps – but a wider spread would be reasonable for a longer projection. Still, any spread above 0.6 would suggest that the historical behavior is not reflected in the model.

2c Tests from the Jagannathan, Kaplin, and Sun (2003) paper about testing CIR models

This paper uses properties of yield curves for expanded model goodness-of-fit tests on the sample data. It compares fits from single-factor, two-factor, and three-factor CIR models. They try several tests, but the two here show ways in which only the three-factor model fits well. They have other tests involving option prices where none of the CIR models work. But since bond option prices depend on stochastic volatility, CIR would not be expected to work. This should not be a problem for the time frames used in P&C models, where the stochastic volatilities average out.

2c.1 Volatility by maturity

They compare volatility by maturity in the sample with that implied by the fits. Figure 8 is their main result for that, and it shows a reasonably good match for the three-factor model. A similar test for simulated data is included in the Feldhütter (2016) discussion above.

Table 5: Weights for the first four principal components of yield changes							
Change in:	3M	2Y	3Y	5Y	7Y	10Y	% Explained
Level	0.123	0.430	0.462	0.450	0.454	0.421	93.7
Slope	-0.866	-0.273	-0.112	0.081	0.223	0.326	3.6
Curvature	0.482	-0.601	-0.288	-0.035	0.355	0.4433	2.0
Factor 4	-0.010	-0.606	0.662	0.235	0.016	-0.3738	0.3

2c.2 Yield curve shapes as described by principal component analysis (PCA) Yield data comes in an array – perhaps rows for each week of observation and columns for each maturity. In their data there are six maturities, so the yield curve at any date can be represented as a vector in six-dimensional space. PCA rotates the axes of this space to put most of the variation into a few dimensions. The first such dimension – i.e., the first principal component – is defined by the line between the two points that are furthest apart in this space. The second axis is the longest line between two points that is perpendicular to the first one, etc. Each axis gives a set of weights for the yields at any date, where the sum product of the weights with the yields is the coordinate on that axis. For interest rates, usually three principal components – often called level, slope, and curvature – are enough to explain most of the variation in the yield curves. That is, there is very little variation in the remaining dimensions. There are standard formulas that produce principal components and software to implement them.

The weights for the first four components for their example are in Table 5, along with the total variance accounted for by each. The first three explain over 99% of the variation in yield curves. Then they look at how well these three principal components can be approximated by the fitted models, using a regression approach. They find that the three-factor model provides a very good approximation to the three principal components, while the other models do not. They conclude that a three-factor CIR can capture the variety of yield curve shapes, but two factors cannot.

With modern fitting, there would be fitted values for each observation, so these could be used to compute fitted principal components for comparison to the actual principal components. That would show how well the fit is able to explain the observed variation in yield curves.

The principal components are essentially two or three new yield curves fit using the observed collection of yield curves. In the example from Jagannathan, Kaplin, and Sun (2003), 94% of the differences among yields across the data set is explained by the first component, and over 97% of the shape differences can be accounted for by regressing each yield curve on the first two components. They stop with three components, which explain 99.3% of the variability.

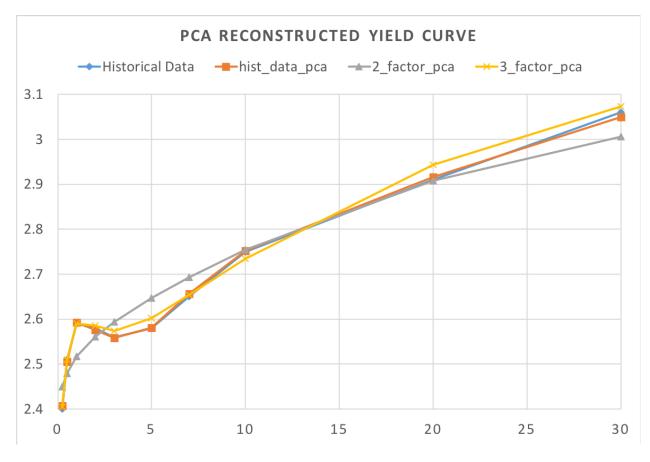


Figure 9: Yield Curve from PCA

For a recent historical dataset, we tried PCA on the actual data, and on two fitted models, which were two and three-factor affine models. These model the yields as linear combinations of partial short rates. Then for each observed time point, we calculated the PCA-fitted yield curves from the three sets of components. Figure 9 graphs the actual and fitted curves at one particular time. This sample has a difficult set of yield curves, due to a reversal in rates from 1 to 5 years. As can be seen, the actual and historical PCA curves are practically identical, and the three-factor model gives a reasonably good approximation. The two-factor model has less flexibility and does not match this particular curve shape.

What we found in doing this exercise, and should have known in advance, is that the two-factor model fits only have two principal components, and the three factor model's have three. That's because the fitted values are linear combinations of two or three sets of short rates. Thus the results of Jagannathan, Kaplin, and Sun (2003) – that the two-factor CIR does not fit the three principal components of actual rates – was more or less pre-ordained. As long as the third actual component is non-trivial, a two-factor model will not have enough variety of curve shapes.

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Table 6: R-Squared by Maturity										
R^2	3M	6M	1Y	2Y	3Y	5Y	7Y	10Y	20Y	30Y
Two-factor fit	95.7%	97.7%	77.6%	94.9%	95.6%	91.6%	96.5%	99.1%	91.7%	81.5%
Three-factor fit	99.4%	99.6%	97.9%	98.1%	99.2%	97.3%	99.6%	99.4%	98.6%	99.2%

This gives another way to do a realism test of simulated yield curves: do a PCA on the set of curves and see if the third component explains enough of the variance – maybe 0.005 or more. An expanded test would be to do a PCA on what is taken to be a relevant historical period, and use that as a guideline on how significant the third component should be.

Another useful indicator of how well the model fits by maturity would be to just compute an R^2 statistic for each maturity. For each maturity, that would be the total variance of the rates at the maturity minus the variance of the model residuals, as a percentage of that total variance. Table 6 illustrates this for the two example models. The problems of the two-factor model show up in some specific maturities.

3 Interest rate models

Generally the academic literature focuses on arbitrage-free models. Some actuarial models do not require that, depending on the applications intended. If the risk of different investment strategies is to be analyzed, having arbitrage possible could easily distort the conclusions. If realistic yield curves are desired, the models should also be arbitrage-free. But if rates for only one or two maturities are to be projected long-term, such constraints might not be necessary. Here we will stick to arbitrage-free models of the whole yield curve.

Lognormal models, like the Libor Market Model, produce more skewed distributions of rates than the historical data supports. They are popular for options' pricing, where the greater skewness may help match market risk pricing of short-term volatility. That is not the main focus of P&C models, though, and so we will use models with normal residuals.

Most popular of these are the affine models. They build up the yield curves from the short rates. In a single-factor model with short-rate r(t) at time t, every maturity τ has a constant term $C(\tau)$ and a factor $D(\tau)$ that do not change over time, with fitted rate $R(t,\tau) = C(\tau) + D(\tau)r(t)$. Thus changes in the yield curve over time depend only on the changes in the short rate r(t). This will make all the yield curves parallel, which is unrealistic.

Multi-factor model postulate short-rate components $r_j(t)$ for each factor j, and constants and factors $C_j(\tau)$ and $D_j(\tau)$ that again do not vary over time. Then $R(t,\tau) = \sum_j [C_j(\tau) + D_j(\tau)r_j(t)]$. Mixtures of processes like that can give a much greater variety of yield-curve shapes, especially mixtures of at least three processes. Still the changes in the yield curves over time come from the short rates components $r_j(t)$, as the $C_j(\tau)$, $D_j(\tau)$ functions still do not vary over time t.

Interest rates are modeled as continuous processes, using Brownian motion, but are fit with discrete data, so can be represented by time-series approximations. (A Brownian motion is a continuous process whose value at any future time is normally distributed with mean equal to the current value and variance equal to the time interval.) Parameters are usually scaled as annual changes, with the rates incremented in fractions of a year dt. For instance, dt might be 0.004, for an increment of 1/250th of a year, which is often used to represent one trading day. The advantage of starting with Brownian motion is that any increment can be taken as an approximation. We will start by assuming an unspecified increment dt.

The basic building blocks of affine models are the CIR and Vasicek processes. These are specified by the distribution of the incremental change dr(t) = r(t + dt) - r(t), which is stochastic. More general affine models are built up as combinations of these two. In both of these processes, the distribution of the increments is normal, which we will write as $\mathcal{N}(\mu, \sigma)$. In the Vasicek process, from Vasicek (1977):

$$dr(t) \sim \mathcal{N}\left([\omega - \kappa r(t)]dt, \sigma \sqrt{dt}\right)$$

where ω, κ, σ are parameters. The square root of dt is taken because the variance is proportional to the time increment dt. The constants $C(\tau), D(\tau)$ for each maturity τ are calculated by closed form but slightly complicated formulas.

The CIR process, from Cox, Ingersoll, and Ross (1985), is similar, with

$$dr(t) \sim \mathcal{N}\left([\omega - \kappa r(t)]dt, \sqrt{\beta r(t)dt}\right)$$

Its incremental variance is proportional to its latest value r(t). The variance parameter here is denoted as β rather than σ^2 because it is not the variance but a factor which when combined with r(t) gives the variance. The processes can be simulated in steps of any desired (but small) dt by sampling from these normal distributions. Also these distributions become the priors for the incremental changes in the values of the processes at each subsequent step when doing Bayesian estimation from the historical processes.

The CIR process cannot go negative: it is a continuous process, so if r(t) = 0, the standard deviation also becomes zero, and the process increments by ωdt , which is positive. However when simulating the process, if it gets to a small positive value, the next discrete simulation can become negative. A work-around derives from the fact that the constantly changing

volatility results in a gamma-like distribution for the process over time. This is actually the non-central chi-squared distribution, and for step size dt, the next value of the process has mean and variance:

$$\mu = r(t)e^{-\kappa dt} + \omega \left(1 - e^{-\kappa dt}\right) / \kappa$$
$$V = \frac{\beta}{2\kappa} \left(1 - e^{-\kappa dt}\right) \left[2r(t)e^{-\kappa dt} + \omega \left(1 - e^{-\kappa dt}\right) / \kappa\right]$$

The non-central chi-square is close to a gamma distribution, so it can be approximated by a gamma distribution with this mean and variance. This way the process would not become negative in simulations.

The long-term variance is $\beta \omega/2\kappa^2$. For the Vasicek process, this is $\sigma^2/2\kappa$. The Vasicek long-term distribution is normal with mean ω/κ and this variance, while the CIR long-term distribution is gamma. Both the variances follow the algorithm: expected value of the process change variance divided by twice the speed of mean reversion. These could be used in the priors for the first values of each process, in that they have been going on a long time.

As discussed below, multifactor processes can have a few Vasicek and CIR processes, or can even include combined forms. The CIR processes must be independent or positively correlated to be arbitrage-free, but Vasicek processes can be positively or negatively correlated. Apparently negatively correlated processes provide a realistic variety of yield curves.

3a Yield curves and market price of risk

Dai and Singleton (2000) provide a comprehensive characterization of affine models. Like Jagannathan, Kaplin, and Sun (2003) also recommend, they focus on three-factor models. We start with three-factor combinations of the Vasicek and CIR models that have closed form $C_i(\tau)$ and $D_i(\tau)$ functions.

The yield-curve formulas are derived as expectations of related risk-neutral processes. The idea of risk-neutral processes is to add risk load directly into the processes, so the expected value of the bond value at maturity discounted along the risk-neutral rate process is the risk-loaded price of the bond. This allows risk loads to be put into bonds of various maturities in a consistent way. The fundamental theorem of asset pricing says that arbitrage-free prices must be the expected values of admissible transformed processes – i.e., ones that do not change the set of outcomes that have non-zero probabilities. Such transforms here change the ω and κ parameters, but not the σ or β parameters.

The simplest transform is called completely affine. Under it, the mean $[\omega - \kappa r(t)]dt$ of these process changes to $[\tilde{\omega} - \tilde{\kappa}r(t)]dt$. This uses a market-price-of-risk parameter λ , which is estimated when fitting the model. For the Vasicek process, it works out that $\tilde{\kappa} = \kappa$ and

 $\tilde{\omega} = \omega - \sigma \lambda$. For the CIR process, on the other hand, $\tilde{\kappa} = \kappa + \beta \lambda$ and $\tilde{\omega} = \omega$. The transformed parameters are called the risk-neutral parameters. The derivation of the $C(\tau)$ and $D(\tau)$ functions assumes that the bond prices are expected values under the transformed process.

There is a more general approach to the market price of risk called essentially affine. It does not affect the previously-transformed CIR process but for each Vasicek process there is another market price parameter ψ . Then

$$\widetilde{\omega} = \omega - \sigma \lambda$$
$$\widetilde{\kappa} = \kappa + \sigma \psi$$

In either case, the values of $C(\tau), D(\tau)$ are derived from the risk-neutral processes. Let $q = \tilde{\omega}/\tilde{\kappa}$. Then for the Vasicek process, the constants $C(\tau), D(\tau)$ are:

$$D(\tau) = \frac{1 - e^{-\tilde{\kappa}\tau}}{\tilde{\kappa}\tau}$$

$$C(\tau) = q - qD(\tau) + \left[\frac{\sigma}{2\tilde{\kappa}}\right]^2 \left[\tilde{\kappa}\tau D(\tau)^2 + 2D(\tau) - 2\right]$$

The CIR formulas require two intermediate values:

$$h = \sqrt{\tilde{\kappa}^2 + 2\beta}$$
$$Q(\tau) = \left[(\tilde{\kappa} + h) \left(e^{h\tau} - 1 \right) + 2h \right]^{-1}$$

Then:

$$C(\tau) = -\frac{\widetilde{\omega}}{\tau\beta} \left(2log[2hQ(\tau)] + \widetilde{\kappa}\tau + h\tau \right)$$

$$D(\tau) = 2Q(\tau) \left(e^{h\tau} - 1\right) / \tau$$

The *D* functions start at 1 for $\tau = 0$ and decline from there. That means that the longer maturities change less as r(t) changes, and so have less volatility than do the shorter maturities. This is a pretty standard property of yield curves but did not hold over much of the last decade. These models would probably not do very well when the short rates are so low. Having greater volatility in the shorter rates also builds in the property that longer spreads get lower when the short rate rises.

The $C(\tau), D(\tau)$ functions depend on $\tilde{\kappa}$ and $\tilde{\omega}$, so some analysts prefer to make these the

primary parameters to estimate, and then calculate κ, ω by reversing the λ and ψ adjustments. In a sense, the $C(\tau)$ and $D(\tau)$ functions basically define the model, as they are constant over time while the short-rates evolve stochastically. Fitting the model then comes down to deriving these functions from the risk-neutral processes. That is why these processes are often taken as the starting point. Doing it this way also seems to help numerically with parameter estimation, as λ and ψ then do not go into estimating the functions. That approach seems to speed up the estimation. However we take it one step further.

For a thee-factor model with one CIR and two Vasiceks, in the completely affine case, this method produces all the risk-neutral parameters, plus three real-world parameters: the CIR κ and the two Vasicek ω s. We actually estimate these directly, and the λ s can be backed out later, if desired. In the essentially affine model it is similar, but now the real-world and risk-neutral parameters can all be estimated independently, just with the CIR $\omega = \tilde{\omega}$. This also holds for the more general models discussed later for the essentially affine risk loads. It is easier for the software to do the estimation this way, as there are less interactions among the parameters that are specified in advance.

In multi-factor models, the CIR and Vasicek processes r_j are taken as unobserved components of the short rate. Any number of independent processes can be combined in this way. Then the yield curves from each model are treated as partial interest rates, and they add up to the interest rates for each maturity. The $C_j(\tau)$ functions add over j, as do the $D_j(\tau)r_j(t)$ terms.

For two correlated Vasicek processes, the $D_j(\tau)r_j(t)$ terms add, but an adjustment to the $C_j(\tau)$ functions is needed. If the correlation is ρ , Brigo and Mercurio (2001), p. 135, as well as Troiani (2017), give the adjustment:

$$C(\tau) = C_1(\tau) + C_2(\tau) + \frac{\rho \sigma_1 \sigma_2}{\tilde{\kappa}_1 \tilde{\kappa}_2} \left[\frac{e^{-\tau(\tilde{\kappa}_1 + \tilde{\kappa}_2)} - 1}{\tau(\tilde{\kappa}_1 + \tilde{\kappa}_2)} + D_1(\tau) + D_2(\tau) - 1 \right]$$

If there are additional independent Vasicek or CIR processes, their C functions add in as well, and so do the $D_j(\tau)r_i(t)$ terms.

Bolder (2001) shows the adjustment for any number of correlated Vasiceks:

$$C(\tau) = \sum_{j} C_{j}(\tau) + \sum_{i,j:j \neq i} \frac{\rho_{ij}\sigma_{i}\sigma_{j}}{\widetilde{\kappa}_{i}\widetilde{\kappa}_{j}} \left[\frac{e^{-\tau(\widetilde{\kappa}_{i}+\widetilde{\kappa}_{j})} - 1}{\tau(\widetilde{\kappa}_{i}+\widetilde{\kappa}_{j})} + D_{i}(\tau) + D_{j}(\tau) - 1 \right]$$

This uses the sum of the correlation adjustments across all of the binary correlations. Multi-factor models allow a slight generalization to the idea that the sum of the vector r(t) of the short-rate components at time t is the actual short rate $r_s(t)$. For instance, three-factor models allow a constant $\delta_0 \geq 0$ and a positive three-vector δ so that $r_s(t) = \delta_0 + \delta' r(t)$. The default assumption, assumed above, is that $\delta_0 = 0$ and $\delta_j = 1, j > 0$. We introduce $\gamma_j = \delta_j - 1 > -1, j > 0$. The result of this is to add δ_0 to $C(\tau)$, and γ_j to $D_j(\tau)$. Dai and Singleton (2000) argue that in a three-factor model, nothing is lost by setting $\gamma_2 = \gamma_3 = 0$. We adopt this approach. Feldhütter (2016) estimates δ_0 and γ_1 as both less than 0.03. He leaves γ_2, γ_3 in the model, but they both come out virtually equal to zero.

All of this provides quite a bit that can be done in closed form. Starting with one CIR and two Vasiceks, you can add correlation to the Vasiceks, which is one more parameter. The Vasiceks can also use essentially affine market prices of risk, adding two more parameters. And two more come from δ_0 and γ_1 . This gives quite a lot of flexibility to the model building. You start off with 3 $\tilde{\kappa}$ parameters, 3 $\tilde{\omega}$'s, 2 σ 's and β to make the $C(\tau), D(\tau)$ functions. The correlation ρ affects those, as do δ_0 and γ_1 . Then the market-price-of-risk adjustments add five more factors to give the real-world yield-curve processes.

The more general affine models, discussed in Appendix 1, require solving systems of ordinary differential equations for the $C(\tau), D(\tau)$ functions. There is convenient software for this, illustrated in the sample code in Appendix 3, but it does add to model fitting time. The fairly complicated formulas for C, D for the CIR and Vasicek models are actually solutions of these differential equations.

In the models discussed so far, the drifts – the incremental mean changes of the processes – depend on the immediately previous values of their processes. The more general models allow the immediately previous values of all the processes to go into the drift of a process. The CIR variance is a multiple of the process itself. In the more general models, every process variance is allowed to be a linear function of the CIR process.

The CIR process is very delicate with respect to any possible generalization and is usually left the same in the more general models. Below is an example of the evolution formula for the first Vasicek process, assumed to be the second process in a model with one CIR and two Vasicek processes:

$$dr_2(t) \sim \mathcal{N}\left(\left[\omega_2 - \kappa_{21} r_1(t) - \kappa_{22} r_2(t) - \kappa_{23} r_3(t) \right] dt, \sigma_2 \sqrt{1 + \beta_2 r_1(t) dt} \right)$$

This lowers subsequent values of this process when any of the processes is high, and also allows the stochastic volatility from the first process to go into each of the process variances. We fit this model below for comparison to the closed-form models. The other Vasicek process is like this one, but has an extra volatility term to produce correlation with this process. The first process is a plain CIR. With essentially affine market price of risk and the δ_0, γ_1 parameters, this is the maximal model we fit. Below we call this model 7k3b, because it has 7 κ 's and 3 β 's. In the general form, the κ 's are in a 3x3 matrix K, but in this CIR, $\kappa_{12} = \kappa_{13} = 0$.

Appendix 2 goes into the model fitting by MCMC. This requires specifying postulated (prior) distributions for the parameters, but these can be changed after seeing the implied conditional distributions of the parameters given the data. Thus they are not exactly like the Bayesian view of prior beliefs. Historical values of $r_j(t)$ are not parameters of the model, but they are projected as a step in parameter estimation. These are not allowed to fluctuate freely, however. Their prior distributions are defined by the process evolution equations. Thus the next value of a process would be normally distributed according to the evolution assumptions of the process. (In MCMC you do not have to specify the form of the posterior (conditional given the data) parameter distributions – they are sampled numerically based on the priors, the likelihood, and the data.) All of this produces projections for the history of the partial short-rate processes r_j , and so also provides fitted values of the yield curve at every time point in the data. More detail is in Appendix 2.

4 Results of Fitting

A key issue in fitting models to yield-curve data is the choice of period and data to use. The models assume zero-coupon bonds, but there is no raw data on those. Some data series have been constructed, for instance by the Wall Street Journal. Here we instead use US Treasury Constant Maturity Rates, available from the St. Louis Fed FRED database (https://fred.stlouisfed.org/categories/115). It would be rare to have bonds on the market that mature in exactly 5 years, for instance, and the Fed estimates 5-year, etc., rates by interpolating related yields on actual trades. These rates assume semi-annual interest payments at whatever rates the actual bonds carry. The data is considered to be estimates of the yields, each with a distribution around the actual rate. We assume these distributions are all normal, with standard deviations = σ_y , which is estimated in the model fitting using the differences of the fitted and observed rates.

Short-rates have come out of the very-low-yield period following the economic crash of 2008, with the Fed increasing their rates a fair amount. Fitting older data would not be representative of the market we are in now, and even starting at the beginning of the period of rate increases creates a problem of models with built-in upward trend. We chose to use week-ending rates from 1/5/2018 to 6/21/2019 for maturities of 1, 2, 3, 5, 7, 10, 20, and 30 years. Rates shorter than this follow the Fed much more than the market so are not really generated from the same process. This is largely true for the one-year rates as well, but they

are too important to leave out. That rate was at 1.82% at the beginning of our data, and ended 1.98%. It got as high as 2.7% along the way. All the other rates also went up for much of this period, but ended up lower than they started. For instance, two-year rates started at 1.95%, got as high as 2.94%, and ended at 1.79%. Thirty-year rates went from 2.8% up to 3.42% then back down to 2.56% The Fed Funds Rate went up for a while then leveled off, not decreasing at the end. The one-year rate seems more influenced by this, and ended higher than the two, three and five-year rates.

We fit four models to that data. VVV is a closed-form model consisting of three correlated Vasicek processes, with essentially affine market prices of risk. This is considered an $A_0(3)$ model as there are three processes and none of them affect the volatility of the rates. The other three models are $A_1(3)$ models, having a single CIR process. CVV is a completely affine model with one CIR and two correlated Vasicek processes. CVV+ is our maximal closed-form model, and is like CVV but is essentially affine and includes parameters for δ_0 and γ_1 . 7k3b is the overall maximal ODE model that we fit. It has 7 κ parameters – all but κ_{12}, κ_{13} – and all three β parameters. The CVV model has 14 parameters – 3 for each risk-neutral process, 3 additional real-world parameters, ρ , and σ_y . VVV has 19 parameters, so 5 more: 2 more correlations, and 6 real-world parameters – a κ and a ω for each process. CVV+ has 18 parameters. It only has 1 correlation, but has δ_0 and γ_1 as well as 5 real-world parameters, as $\tilde{\omega}_1 = \omega_1$. 7k3b actually has 10 more parameters than this, so 28 in total. Compared to CVV+ it has 4 more $\tilde{\kappa}$ s, 2 more β s, and 4 more κ s.

Table 7 shows the fitted parameters for each model, along with: σ_y ; the implied realworld model means μ_j for each process and their implied total short rate; the loo penalized loglikelihood goodness-of-fit measure for MCMC fits; the loo penalty for parameters (difference from LL); and the implied loglikelihood.

The VVV model does not fit as well as any of the CIR models, according to loo. The Vasicek and CIR yield curves can have somewhat different shapes, which could be contributing to this. Also stochastic volatility may be a feature of the data, and Vasicek models do not capture that. The essentially affine version of the CVV model, including the δ_0 , γ_1 adjustments to the $C(\tau)$, $D(\tau)$ functions, is better-fitting than the basic version. The full model, even when considering all the additional parameters, is better yet, both in loo and the residual standard deviation σ_y . The 10 additional parameters make the model much more flexible, and apparently this data can make use of that flexibility.

All of the projected short-rates (here for 3 processes and 77 data points, so 231 in total) are considered parameters for testing goodness of fit, in addition to the model parameters and

Та	ble 7: Fit	tted Mod	lels	
Variable	VVV	CVV	CVV+	7k3b
$\widetilde{\omega}_1$	-30.3	1.33	1.19	0.113
$\widetilde{\omega}_2$	-0.627	-62	-19.28	-2.758
$\widetilde{\omega}_3$	30.3	62.2	19.91	1.649
$\widetilde{\kappa}_{11}$	0.07	0.027	0.165	0.007
$\widetilde{\kappa}_{22}$	1.076	0.063	0.07	0.330
$\widetilde{\kappa}_{33}$	0.055	0.052	0.047	0.224
$\widetilde{\kappa}_{21}$	-	-	-	0.047
$\widetilde{\kappa}_{23}$	-	-	-	0.122
$\widetilde{\kappa}_{31}$	-	-	-	-0.708
$\widetilde{\kappa}_{32}$	-	-	-	-0.933
σ_1	1.64	1	1	1
σ_2	0.83	2.58	1.17	0.159
σ_3	1.92	2.9	1.31	0.071
eta_1	-	1.85	1.19	9E-05
eta_2	-	-	-	1.078
eta_3	-	-	-	2.703
ω_1	24.1	1.33	1.19	0.113
ω_2	-0.296	-0.596	7.045	-6.626
ω_3	-19.2	0.43	-22.272	2.908
κ_{11}	0.972	2.432	1.8667	0.012
κ_{22}	1.906	-	0.7369	0.918
κ_{33}	1.0534	-	2.4443	1.094
κ_{21}	-	-	-	0.023
κ_{23}	-	-	-	-0.678
κ_{31}	-	-	-	0.133
κ_{32}	-	-	-	-0.228
$ ho_{12}$	0.17	-	-	-
$ ho_{13}$	-0.93	-	-	-
$ ho_{23}$	-0.47	-0.96	-0.81	-0.65
δ_0	-	-	0.021	0.253
γ_1	-	-	-0.032	0.001
σ_y	0.025	0.023	0.023	0.019
μ_1	9.41	0.55	0.64	9.52
μ_2	-0.46	-13.05	9.36	-5.7
μ_3	-6.35	6.2	-9.09	-0.05
Mean short rate	2.6	-6.3	0.91	4.02
loo	1312.9	1324.7	1333.3	1462.1
penalty	134	175.7	184.2	183.5
LL	1446.9	1500.4	1517.5	1645.6

the market prices of risk. Thus there are between 245 and 259 parameters that go into the parameter penalty. The penalties are much less than this, and are not always higher with more parameters.

The loo penalty is not calculated as a multiple of the number of parameters but rather comes from a cross-validation approach. The penalized loglikelihood is an estimate of the loglikelihood (LL) of the fitted model for a new independent sample. The penalty is how much lower the penalized likelihood is from the actual LL. It is an estimate of the sample bias, which tends to increase for more parameters, but not in a readily-predictable way for non-linear models like these. The penalties here are less than the actual number of parameters partly because the estimated historical short-rates are highly constrained and do not act like independent parameters.

Ye (1998) defines the generalized degrees of freedom used by a data point in a nonlinear model as the derivative of the fitted point wrt the actual data point. These derivatives constitute the diagonal of the hat matrix in linear models. The sum of the resulting dofs is the effective number of parameters, and these can then be penalized by AIC, etc. Constrained parameters do not give the data points much power to move the fitted values towards them, so the derivatives and the effective number of parameters are reduced. Something similar happens in loo. The loglikelihood at a point is penalized by how much it would be reduced if that point were left out of the sample. Again if the parameters are highly constrained, the loglikelihood at a point is not affected much by leaving it out of the estimation.

Figures 10 and 11 show the fitted short rates, the $C(\tau), D(\tau)$ functions, and the resulting rate fits for the 7k3b model.

5 Applying Tests

We now apply several of the tests from Section 2 to the VVV and 7k3b models for illustration. We first extracted the sampled parameter distributions from the Stan output for each model. Then we simulated two years of future rates for the two models, and these simulated yield curves were the used for the tests. This is similar to the common situation of the insurer only having the generated scenario sets and not the model fitting comparisons.

The simulations started from the sampled parameter distributions, which is a way of including parameter uncertainty. Each simulation starts by drawing a parameter sample at random. Then the ending values of the three processes in that sample are the starting previous values for their first simulations. The simulations are done by computing the drift and the variance using the real-world processes, then doing a random draw for the next value of each process. The C and D functions (already in the parameter samples) are based on the risk-neutral

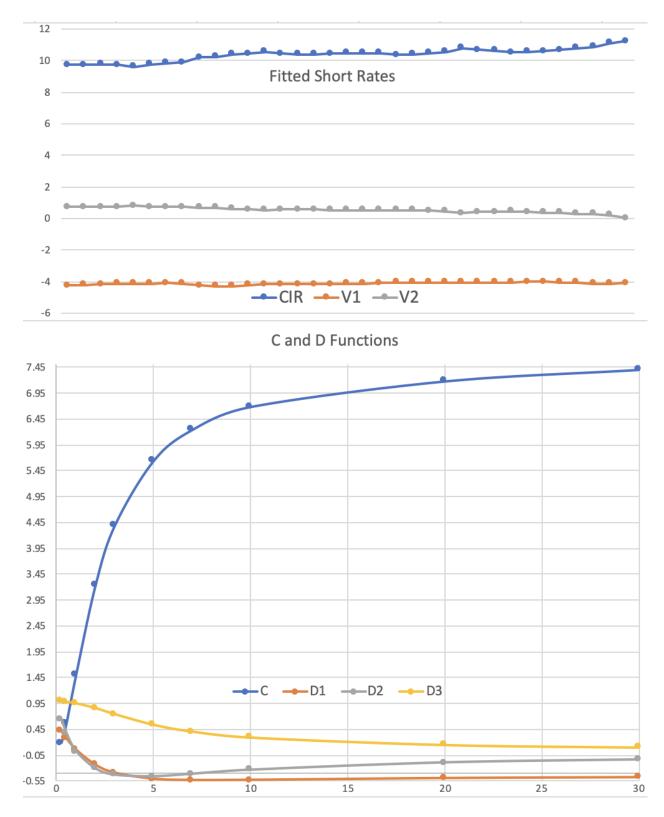


Figure 10: Projected Historical Short Rates and C, D Functions

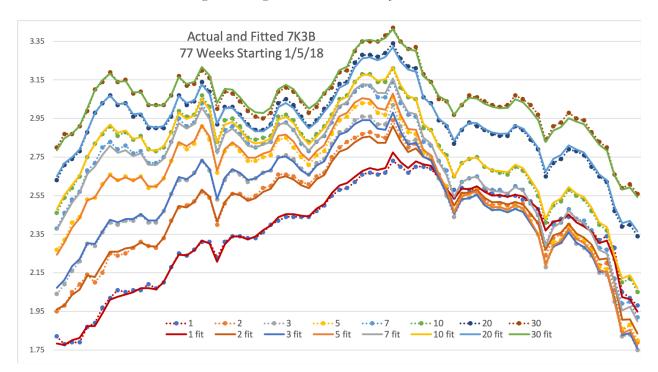


Figure 11: Actual vs. Fitted Yield Curves

processes and are not simulated except as implied by the draw of the sample. We simulate at monthly intervals for two years for each process, and the two year-ending yield curves are used in the tests.

Table 8 shows the moments of the simulated rates for the two models by year. The mean yield curves are basically upward for the VVV model, while the 7k3b model projects the current curve shape, which is high on both ends and low in the middle, which seems better. The standard deviations generally decline with maturity, which is probably all you can look for there at this point, as the right shape of the volatilities by maturity is still emerging. The skewness is moderately negative for the VVV model, indicating more downward risk in yields. It is also negative for the longer rates in the 7k3b model, but is positive for the shorter rates. That could be coming from the recent experience, which had movements like that.

Table 9 has the spread regressions for the 3-year – 30-year spreads as a function of the 1-year rates and the Campbell-Schiller regressions for 2 and 3-year rates. The spread regressions' slopes and standard errors are compatible with recent history for 7k3g but are pretty small for VVV. The expected slopes for the Campbell-Schiller regressions are negative. That is all consistent with the targets for these tests, and what we would want for the exact magnitudes of the slopes is not clear beyond those signs.

We did principal component analysis on the actual data, the fitted means for all four models,

Table 8: Scenario Moments								
Maturity	1	2	3	5	7	10	20	30
VVV Year 1								
mean	1.90	1.87	1.89	1.97	2.06	2.18	2.48	2.70
std	0.40	0.44	0.46	0.47	0.47	0.45	0.38	0.32
skw	-0.55	-0.50	-0.45	-0.41	-0.39	-0.37	-0.35	-0.34
VVV Year 2								
mean	1.94	1.92	1.95	2.03	2.12	2.24	2.52	2.73
std	0.53	0.56	0.58	0.58	0.57	0.54	0.45	0.38
skw	-0.86	-0.77	-0.71	-0.64	-0.61	-0.59	-0.55	-0.53
7k3b Year 1								
mean	2.74	2.56	2.45	2.38	2.42	2.51	2.71	2.86
std	0.82	0.76	0.76	0.73	0.68	0.60	0.45	0.40
skw	0.18	0.04	-0.08	-0.23	-0.28	-0.30	-0.30	-0.30
7k3b Year 2								
mean	3.29	2.85	2.57	2.32	2.30	2.39	2.65	2.82
std	1.47	1.01	0.90	0.93	0.92	0.83	0.59	0.49
skw	0.94	0.68	0.24	-0.85	-1.20	-1.27	-1.02	-0.78

 Table 9: Scenario Regressions

	Spread Slope	Spread SE	Campbell-Schiller Slope
VVV Year 1 (2 Year τ for C-S)	-0.42	0.01	-0.99
VVV Year 2 (3 Year τ for C-S)	-0.29	0.01	-1.63
7k3b Year 1 (2 Year τ for C-S)	-0.61	0.06	-2.63
7k3b Year 2 (3 Year τ for C-S)	-0.45	0.09	-1.99

and the two years of simulated scenarios for the VVV and 7k3b models. For this we used the R function prcomp, which takes as input an array, with the variables in the columns and the observation times in rows. The first three components explain the vast majority of the variation in the data. An indicator of the degree of complexity of the yield curves is provided by the percentage of variance explained by the third principal component. This is small for the short time period we have, but was greatest in the data itself, and was higher for the fitted values than for the simulated scenarios. The VVV model looks too weak in the third PC's proportion of variance in the simulations. Table 10 shows the results.

Conclusion

The last 30 or 40 years of yield curve history, instead of being the new normal, are starting to look more like a one-time aberration, driven by the post-WWII financing needs. We are now seeing interest rates more like the 1870 - 1970 period, where the long rates rarely got above 4%. This makes constructing tests based on yield-curve standard behavior challenging.

We started by reviewing the tests that had been used historically in the related literature. Most of them are still useful with updated targets, although these are fairly broad given the uncertainty about the properties of interest rates in the emerging era. We applied the tests to a few models fit to recent data, and the models did reasonably well in the context of these broad guidelines, with the better-fitting model also doing better on the tests.

The models used were affine models, which build up the yield curves as weighted sums of partial short-rate processes. The weights for this are time invariant but are a bit complicated to calculate, and for the most general models require numerical solutions of ordinary differential equations. Several closed form models where the differential equations have been solved in closed form provide reasonable fits, but not as good as the more general models.

MCMC estimation provides a direct way to fit the models, and produces fitted values for the historical processes.

Table 10: PCA		risons	
data	PC1	PC2	PC3
Standard deviation	0.657	0.254	0.083
Proportion of Variance	0.857	0.128	0.014
Cumulative Proportion	0.857	0.985	0.999
fit vvv	PC1	PC2	PC3
Standard deviation	0.655	0.251	0.070
Proportion of Variance	0.863	0.127	0.010
Cumulative Proportion	0.863	0.990	1.000
fit cvv	PC1	PC2	PC3
Standard deviation	0.656	0.252	0.074
Proportion of Variance	0.862	0.127	0.011
Cumulative Proportion	0.862	0.989	1.000
fit cvv+	PC1	PC2	PC3
Standard deviation	0.655	0.253	0.074
Proportion of Variance	0.861	0.128	0.011
Cumulative Proportion	0.861	0.989	1.000
fit 7k	PC1	PC2	PC3
Standard deviation	0.657	0.254	0.079
Proportion of Variance	0.859	0.128	0.013
Cumulative Proportion	0.859	0.987	1.000
vvv yr1	PC1	PC2	PC3
Standard deviation	1.189	0.187	0.062
Proportion of Variance	0.973	0.024	0.003
Cumulative Proportion	0.973	0.997	1.000
vvv yr2	PC1	PC2	PC3
Standard deviation	1.481	0.211	0.072
Proportion of Variance	0.978	0.020	0.002
Cumulative Proportion	0.978	0.998	1.000
7k yr1	PC1	PC2	PC3
Standard deviation	3.067	0.749	0.165
Proportion of Variance	0.789	0.203	0.009
Cumulative Proportion	0.789	0.991	1.000
7k yr2	PC1	PC2	PC3
Standard deviation	1.975	1.734	0.222
Proportion of Variance	0.561	0.432	0.007
Cumulative Proportion	0.561	0.993	1.000
-			

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Appendix 1 – General Affine Models

A1a Matrix Notation

We follow the notation of Dai and Singleton (2000) for affine models. The model combining two Vasiceks and one CIR is classified as an $A_1(3)$ model. That means that there are three processes, with one of them affecting the variance – in this case the CIR process. For consistency with more general models, we replace κ_j with κ_{jj} and σ_j with σ_{jj} . Then our model, with the CIR model first, can be written:

$$dr_1(t) \sim \mathcal{N}\left([\omega_1 - \kappa_{11}r_1(t)]dt, \sqrt{\beta_1r_1(t)dt}\right)$$
$$dr_2(t) \sim \mathcal{N}\left([\omega_2 - \kappa_{22}r_2(t)]dt, \sigma_{22}\sqrt{dt}\right)$$
$$dr_3(t) \sim \mathcal{N}\left([\omega_3 - \kappa_{33}r_3(t)]dt, \sigma_{33}\sqrt{dt}\right)$$
$$corr\left(dr_2(t), dr_3(t)\right) = \rho$$

While this is a convenient way to show the correlation, more calculation detail is needed for use as a prior or for simulation. The bivariate normal prior can be used for the two Vasicek processes, specifying their covariance matrix as:

$$Cov(dr_2(t), dr_3(t)) = \begin{pmatrix} \sigma_{22}^2 & \rho \sigma_{22} \sigma_{33} \\ \rho \sigma_{22} \sigma_{33} & \sigma_{33}^2 \end{pmatrix} dt$$

We do that in the code. For simulation, it is useful to be able to show these evolution equations in terms of independent standard normal draws. For this we write $dr_j(t) = \mu_j(t)dt + z_j(t)\sqrt{dt}$, where $z_j(t)dt$ is a mean zero normal variable. Also we define $\epsilon_j(t)$ to be a standard normal random variable observed at time t. Then the vector z(t)dt that combines the three processes can be expressed as:

$$z(t)\sqrt{dt} = \begin{pmatrix} \sqrt{\beta_1 r_1(t)} & 0 & 0\\ 0 & \sigma_{22} & 0\\ 0 & \rho\sigma_{22} & \sqrt{1-\rho^2}\sigma_{33} \end{pmatrix} \begin{pmatrix} \epsilon_1(t)\\ \epsilon_2(t)\\ \epsilon_3(t) \end{pmatrix} \sqrt{dt}$$

This now can be set up in matrix notation as the evolution of a vector of three processes. Let r(t) be a column vector of the three processes, with $dr(t) \sim \mu(t)dt + z(t)\sqrt{dt}$, and vector of standard normals $\epsilon(t)$. Then the general $A_1(3)$ model diffusion can be expressed by:

$$\mu(t)dt = [\Omega - Kr(t)]dt$$

$$z(t)\sqrt{dt} = \Sigma D(t)\epsilon(t)\sqrt{dt}$$

where: K is the 3x3 matrix of $\kappa_{i,j}$, with $\kappa_{12} = \kappa_{13} = 0$; Ω is a 3-vector; Σ is the matrix of $\sigma_{i,j}$ values, with $\sigma_{11} = 1, \sigma_{12} = \sigma_{13} = 0$ and ρ combined into the σ coefficients; D(t) is a diagonal matrix with the three values $\sqrt{\beta_1 r_1(t)}, \sqrt{\alpha_2 + \beta_2 r_1(t)}, \sqrt{\alpha_3 + \beta_3 r_1(t)}$, with all β_j non-negative and β_1 positive. This allows the CIR process to also contribute to the variances of the other processes. D^2 is a variance factor, scaled by Σ^2 . We are going to assume that $\alpha_2 = \alpha_3 = 1$ in the fitting, as the σ 's can pick up a lot of the α effects.

Such general $A_1(3)$ models provide for interaction among the processes. For the two Vasicek processes, σ_{32} takes the place of $\rho\sigma_{22}$. We set $\sigma_{23} = 0$ for identifiability, but this is not always done. The off-diagonal κ terms make a Vasicek process's mean movements responsive to the current levels of both other processes, as well as its own. That cannot be done for the CIR process, as it can easily lose its arbitrage-free property with any adjustments.

Some constraints on the parameters are needed for identifiability. Dai and Singleton (2000) set up a canonical form of the model that builds in numerous constraints, but it is not clear how our original three-factor model would be expressed in it, so we rely instead on the use of priors on the parameters to get unique parameters. The yield curves are built up from the short rates using market prices of risk. The CIR and Vasicek market prices of risk discussed previously are special cases. Here we follow Christensen (2015) who clarifies the notation and provides examples.

A1b Market Price of Risk and Bond Yields

The basic form of market price of risk is the completely affine risk premium. It uses a 3-vector $\Lambda(t) = D(t)\lambda$, where λ is a 3-vector of constants. The risk-neutral process is produced by a change in the drift term. $\Sigma D(t)\Lambda(t)dt$ is subtracted from the drift $[\Omega - Kr(t)]dt$. Some algebra on this can then be used to express the risk-neutral drift term as $[\tilde{\Omega} - \tilde{K}r(t)]dt$, and this is used to compute the yield curve, as it was in the three-factor model above.

The term subtracted is similar to the stochastic term of the process. We need to compute:

$$\widetilde{\Omega}dt - \widetilde{K}r(t)dt = \Omega dt - Kr(t)dt - \Sigma D(t)\Lambda(t)dt$$

The right side of this is already the risk-neutral drift, but the formulas for the yield curve use the notation of the left side, so we have to put it in that form. For the completely affine case, $\Sigma D(t)\Lambda(t)dt = \Sigma D(t)^2\lambda$, where $D(t)^2$ is diagonal with elements $\alpha_j + \beta_j r_1(t)$. Then $D(t)^2\lambda$ is the vector with elements $\lambda_j[\alpha_j + \beta_j r_1(t)]$, which means that $\Sigma D(t)\Lambda(t)$ is a 3-vector, but with $\alpha_1 = 0$. Each element is a sum of multiples of α_j and $\beta_j r_1(t)$ terms. The terms with α_j 's are subtracted from the ω_j 's terms, and this gives $\tilde{\Omega}$. All the factors with $\beta_j r_1(t)$'s are subtracted from the drift, so the coefficients of $r_j(t)$ are added to K to produce \tilde{K} . Also note that the stochastic part of the process does not change in the risk-neutral process.

Dai and Singleton (2000) solve some of this for any $A_1(3)$ model. Let L be the diagonal matrix with elements $\lambda_j \beta_j$ and H be the vector of $\lambda_j \alpha_j$. Then $\widetilde{K} = K + \Sigma L$, and $\widetilde{\Omega} = \Omega - \Sigma H$. In practice we reverse this for estimation efficiency, so we start with the risk-neutral process and get the real-world process by $K = \widetilde{K} - \Sigma L$, and $\Omega = \widetilde{\Omega} + \Sigma H$.

Above we used formulas from Brigo and Mercurio (2001) to compute the $C(\tau)$ and $D_j(\tau)$ functions in the correlated Vasicek case. Troiani (2017) illustrate these formulas for the essentially affine case. For more general models, C and D_j functions are not closed form and need to be computed numerically, from systems of ordinary differential equations (ODEs). Fast software for solving ODEs is widely available. The closed-form calculation is considerably faster, but solving the system numerically is feasible on personal computers. That's why these functions are considered to be "almost closed form."

The system for the $A_1(3)$ models is expressed in terms of functions $A(\tau)$ and $B_j(\tau)$, with $C(\tau) = -A(\tau)/\tau$ and $D_j(\tau) = B_j(\tau)/\tau$. *B* is the vector of the B_j 's. Let $Q(\tau) = \Sigma' B(\tau) B(\tau)' \Sigma$, which is 3x3 and can be considered to be the square of the three-vector $\Sigma' B(\tau)$. The *j*th element on the diagonal of *Q* is the square of the *j*th element of $\Sigma' B(\tau)$, so $Q_{jj} = ([\Sigma' B(\tau]_j)^2$. Also let $\beta 0_j$ be the vector consisting of β_j followed by two zeros. The equations are then:

$$\frac{dA(\tau)}{d\tau} = -\widetilde{\Omega}'B(\tau) + \frac{1}{2}\sum_{j=1}^{3}([\Sigma'B(\tau)]_j)^2\alpha_j$$
$$\frac{dB(\tau)}{d\tau} = \mathbf{1} - \widetilde{K}'B(\tau) - \frac{1}{2}\sum_{j=1}^{3}([\Sigma'B(\tau)]_j)^2\beta_0$$

Here **1** is a vector of 1's. The starting values are $A(0) = B_j(0) = 0$.

We have been assuming that the sum of the vector r(t) of the three short-rate components is the actual short rate $r_s(t)$. But affine models allow a slight generalization of that with a constant δ_0 and a three-vector δ so that $r_s(t) = \delta_0 + \delta' r(t)$. The differential equations above are based on the default assumptions that $\delta_0 = 0$ and $\delta = \mathbf{1}$. We set $\gamma = \delta - \mathbf{1}$. Then the differential equations become:

$$\frac{dA(\tau)}{d\tau} = -\widetilde{\Omega}'B(\tau) + \frac{1}{2}\sum_{j=1}^{3}([\Sigma'B(\tau)]_j)^2\alpha_j - \delta_0$$

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$$\frac{dB(\tau)}{d\tau} = \gamma + \mathbf{1} - \widetilde{K}'B(\tau) - \frac{1}{2}\sum_{j=1}^{3} ([\Sigma'B(\tau)]_j)^2 \beta 0_j$$

This ends up subtracting $\delta_0 \tau$ from $A(\tau)$ and adding $\gamma \tau$ to $B(\tau)$. Thus $C(\tau)$ is increased by δ_0 and $D_j(\tau)$ is increased by γ_j . Dai and Singleton (2000) assume $\delta_0 \ge 0$ and $\gamma_2 = \gamma_3 = 0$. Feldhütter (2016) estimates δ_0 and γ_1 as both less than 0.03. These same adjustments to C and D can be done for the closed form cases as well, as discussed before.

A1c Essentially Affine Market Price of Risk

Analysts have generally concluded that completely affine risk premiums are overly restrictive on yield-curve dynamics. Recall that these subtract $\Sigma D(t)\Lambda(t)dt$ from the drift $[\Omega - Kr(t)]dt$, where $D(t)\Lambda(t)$ is set to $D(t)^2\lambda$, with λ a 3-vector. Greater flexibility is provided by the essentially affine risk premium, with $D(t)\Lambda(t) = D(t)^2\lambda + J\Psi r(t)$. Here J is a diagonal matrix with elements $0, \alpha_2^{-1/2}, \alpha_3^{-1/2}$, and Ψ is a 3x3 matrix with the first row all zeros. This makes $D(t)\Lambda(t) =$

$$\begin{pmatrix} \beta_1 r_1(t) & 0 & 0 \\ 0 & \alpha_2 + \beta_2 r_1(t) & 0 \\ 0 & 0 & \alpha_3 + \beta_3 r_1(t) \end{pmatrix} \begin{pmatrix} \lambda_1 \\ \lambda_2 \\ \lambda_3 \end{pmatrix} + \begin{pmatrix} 0 & 0 & 0 \\ 0 & \alpha_2^{-1/2} & 0 \\ 0 & 0 & \alpha_3^{-1/2} \end{pmatrix} \begin{pmatrix} 0 & 0 & 0 \\ \psi_{21} & \psi_{22} & \psi_{23} \\ \psi_{31} & \psi_{32} & \psi_{33} \end{pmatrix} \begin{pmatrix} r_1(t) \\ r_2(t) \\ r_3(t) \end{pmatrix}$$

Multiplying by Σ shows that $(0, \sigma_{22}\lambda_2\alpha_2, \sigma_{33}\lambda_3\alpha_3)$ ' is subtracted from Ω , all of the other pieces are added to K. Alternatively, starting with the risk-neutral coefficients can produce the real-world coefficients.

A1d Our maximal model

The maximal model that we fit, which we call 7k3b, is the full general model with the following restrictions:

- Σ is diagonal except for $\sigma_{32} = \rho \sigma_{22}$, with $\sigma_{33} = \sqrt{1 \rho^2} \sigma_3$, where σ_3 is the standard deviation of the original correlated second Vasicek process.
- $\sigma_{11} = 1$
- $\kappa_{12} = \kappa_{13} = 0$
- $\alpha_2 = \alpha_3 = 1$

This means that in the model $dr(t) \sim \mu(t)dt + z(t)\sqrt{dt}$

$$\mu(t) = \begin{pmatrix} \omega_1 \\ \omega_2 \\ \omega_3 \end{pmatrix} - \begin{pmatrix} \kappa_{11} & 0 & 0 \\ \kappa_{21} & \kappa_{22} & \kappa_{23} \\ \kappa_{31} & \kappa_{32} & \kappa_{33} \end{pmatrix} r(t)$$

$$z(t) = \begin{pmatrix} 1 & 0 & 0 \\ 0 & \sigma_{22} & 0 \\ 0 & \sigma_{32} & \sigma_{33} \end{pmatrix} \begin{pmatrix} \sqrt{\beta_1 r_1(t)} \epsilon_1(t) \\ \sqrt{1 + \beta_2 r_1(t)} \epsilon_2(t) \\ \sqrt{1 + \beta_3 r_1(t)} \epsilon_3(t) \end{pmatrix} = \begin{pmatrix} \sqrt{\beta_1 r_1(t)} \epsilon_1(t) \\ \sigma_{22} \sqrt{1 + \beta_2 r_1(t)} \epsilon_2(t) \\ \sigma_{32} \sqrt{1 + \beta_2 r_1(t)} \epsilon_2(t) + \sigma_{33} \sqrt{1 + \beta_3 r_1(t)} \epsilon_3(t) \end{pmatrix}$$

There are thus 7 κ s and 3 β s. The variances of these processes over a short time dt are: $\beta_1 r_1(t), \sigma_{22}^2(\beta_2 r_1(t) + 1)dt, [\sigma_{32}^2(\beta_2 r_1(t) + 1) + \sigma_{33}^2(\beta_3 r_1(t) + 1)]dt$. The last is from the sum of two normal distributions. The covariance of the two Vasicek processes is $\sigma_{22}\sigma_{32}(1 + \beta_2 r_1(t))dt$.

The risk-adjustment for the essentially affine version for this model comes from

$$D(t)\Lambda(t) = \begin{pmatrix} \lambda_1\beta_1r_1(t) \\ \lambda_2 + \lambda_2\beta_2r_1(t) \\ \lambda_3 + \lambda_3\beta_3r_1(t) \end{pmatrix} + \begin{pmatrix} 0 \\ 2_1r_1(t) + \psi_{22}r_2(t) + \psi_{23}r_3(t) \\ 3_1r_1(t) + \psi_{32}r_2(t) + \psi_{33}r_3(t) \end{pmatrix}$$

Then

$$\Sigma D(t)\Lambda(t) = \begin{pmatrix} \lambda_1\beta_1r_1(t) \\ \sigma_{22}\lambda_2 + \sigma_{22}\lambda_2\beta_2r_1(t) \\ \sigma_{32}\lambda_2 + \sigma_{32}\lambda_2\beta_2r_1(t) + \sigma_{33}\lambda_3 + \sigma_{33}\lambda_3\beta_3r_1(t) \end{pmatrix}$$

$$\sigma_{22}\psi_{21}r_{1}(t) + \sigma_{22}\psi_{22}r_{2}(t) + \sigma_{22}\psi_{23}r_{3}(t)$$

$$\sigma_{32}\psi_{21}r_{1}(t) + \sigma_{32}\psi_{22}r_{2}(t) + \sigma_{32}\psi_{23}r_{3}(t) + \sigma_{33}\psi_{31}r_{1}(t) + \sigma_{33}\psi_{32}r_{2}(t) + \sigma_{33}\psi_{33}r_{3}(t)$$

From above, the r_2 mean for this model is:

$$\mu_2(t) = \omega_2 - \kappa_{21}r_1(t) - \kappa_{22}r_2(t) - \kappa_{23}r_3(t)$$

Starting with the risk-neutral version, we can see that $\omega_2 = \tilde{\omega}_2 + \sigma_{22}\lambda_2$. Also, $\kappa_{21} = \tilde{\kappa}_{21} - \sigma_{22}(\lambda_2\beta_2 + \psi_{21})$, from the middle row of z(t). The other coefficients are calculated similarly.

As the real-world parameters are linear combinations of the risk-neutral parameters and the market-price-of-risk parameters, we can fit the risk-neutral and real-world parameters separately and then back out the market-price-of-risk parameters if we want them. It is just necessary to keep $\omega_1 = \tilde{\omega}_1$. This seems to make it easier and faster for the Stan software. Perhaps Stan uses numerical derivatives of the posterior probabilities with respect to the parameters as a fitting step, and having the real-world and risk-neutral parameters related algebraically complicates this.

The reverting mean of the CIR process is $\mu_1 = \omega_1/\kappa_{11}$, as it is for any CIR process. For the Vasicek processes, the changes to the next period will have mean zero if all the processes are at their means. A little algebra can give these means. First, let $w_2 = \omega_2 - \kappa_{21}\mu_1$ and $w_3 = \omega_3 - \kappa_{31}\mu_1$. Also define $\kappa_{\Delta} = \kappa_{22}\kappa_{33} - \kappa_{23}\kappa_{32}$. Then $\mu_2 = (\kappa_{33}w_2 - \kappa_{23}w_3)/\kappa_{\Delta}$ and $\mu_3 = (\kappa_{22}w_3 - \kappa_{32}w_2)/\kappa_{\Delta}$.

The long-term variances of the Vasicek processes, calculated as expected incremental variance for one year divided by twice the speed of mean reversion, come out: $0.5\sigma_{22}^2 (\beta_2\omega_1/\kappa_{11}+1)/\kappa_{22}$ and $0.5 [\sigma_{32}^2(\beta_2\omega_1/\kappa_{11}+1) + \sigma_{33}^2(\beta_3\omega_1/\kappa_{11}+1)]/\kappa_{33}$.

A1e Unspanned Stochastic Volatility (USV)

In an $A_1(3)$ model, or any model that includes a single CIR component, the current variance of the CIR piece is a constant multiple of the latest value of that process, and the other variances are linear functions of the CIR process. That means that the variance of a rate can be expressed as a linear function of all the rates. This is also the case when there are multiple CIR processes. The value of the processes at any point in time can be estimated from the $C(\tau), D_j(\tau)$ values at each maturity and the current rates. Thus the variance at any time can be well estimated by a regression on the rates.

This turns out not to be true of actual rates. Typically a regression like that has an R^2 of about 20%. Collin-Dufresne, Goldstein, and Jones (2003) call this situation "unspanned stochastic volatility." Knowing the yield curve at a given time is not enough to know the variances of the rates. Since it would be enough in $A_1(3)$ generated rates, these models have too close a relationship among the rates and their volatilities.

Collin-Dufresne, Goldstein, and Jones (2003) then look for affine models that have stochastic volatility but for which the variance cannot be computed as a linear function of the rates. They come up with a closed-form $A_1(3)$ model with a lot of related parameters which interact to produce $D(\tau) = 0$ for the CIR process. Then the rates are not a linear function of the CIR process, even though its variance does affect the other processes. Apparently their model did not fit very well, however. Because only two factors enter into the rate calculation, it acts more like a two-factor model, for PCA for example.

Joslin (2018) comes up with general constraints for an affine model to display USV, and gives an $A_1(4)$ example. Filipovic, Larsson, and Statti (2018) work out conditions for an $A_3(3)$ model – 3 CIRs – to have USV. USV models do not necessarily fit better – this is more of a constraint, like being arbitrage-free. We found in our own fitting that mistakes in our code that gave models that were not arbitrage-free often produced better fits. This is typical for constraints. Similarly, adding more data to the fit usually makes the fit a bit worse for the original smaller dataset.

Appendix 2 – Fitting models by MCMC

MCMC (Markov Chain Monte Carlo) estimation simulates sample sets of parameter estimates. It requires a postulated distribution for each parameter and samples from the conditional distribution of the parameters given the data, using efficient numerical techniques. Sometimes it is presented in a Bayesian context, with the postulated distributions labeled as the priors and the conditional distributions called posteriors. However these priors often have no connection to any prior beliefs, or any subjective view of probability, and Bayes Theorem is not needed to sample from the conditional distributions. The postulated distributions can be revised in response to the conditional distributions they generate. MCMC can be done in a frequentist context if the parameters are instead treated as being random effects with the postulated distributions. We will use the prior/posterior terminology, but with the understanding that they are not the same as prescribed by traditional Bayesian methods, and also have a frequentist interpretation.

MCMC has goodness of fit measures analogous to the AIC, BIC, etc., the best one being the leave-one-out (loo) loglikelihood. From the sample of estimates it is possible to numerically approximate what the likelihood would be for a point from a fit done with the data excluding that point – basically by giving more weight to the parameter sets that fit worst at this point. Loo is a good estimate of what the loglikelihood would be for an entirely new sample using the parameters fit to this sample, which is the goal of the AIC measure as well. All of this is in line with the idea that model estimation should optimize the fit to the entire population instead of optimizing the fit to the given sample.

MCMC fitting of yield-curve models includes an intermediate calculation of the $r_j(t)$ values for each process j at each point in time t. These are not parameters of the model per se, but are still given priors and produce posteriors. The estimation assumes that there is noise in the observation process. The interest rates by maturity produced by a model are the estimated mean values, and the data is (typically) assumed to be normally distributed with those means and variance σ_y . The likelihood function is calculated from those probabilities.

In the CVV model, we start with four parameters for each process: $\tilde{\kappa}, \tilde{\omega}, \omega$ and σ or β . Those are all given wide-enough priors so that the priors do not restrict the conditional distributions.

Sometimes the priors have to be narrowed to exclude poor-fitting local maxima, and possibly to speed the calculations. We use normal priors, but for parameters that must be positive, we use gamma priors or give their logs normal or uniform priors. This eliminates a problem with wide priors over-estimating positive parameters. A similar prior is used for σ_y . The prior for ρ is initially uniform(-1, 1). These parameters are then used to calculate the $C(\tau)$ and $D_i(\tau)$ functions according to the formulas above.

The first $r_j(t)$ for each process is given the prior of the long-term distribution of the process defined by the parameters, so is gamma with mean ω/κ and variance $\beta\omega/2$ for the CIR, and is normal $(\omega_j/\kappa_j, \sigma_j^2/2\kappa_j)$ for the Vasicek processes. This is like assuming that the process has been going a long time up to that point.

Then the sample value at $r_j(t)$ is used to produce the prior for the process at the next period $r_j(t + dt)$, using the evolution equations for the processes. Each Vasicek prior for $r_j(t + dt)$ is normal with mean $r_j(t) + [\omega_j - \kappa_j r_j(t)]dt$ and variance $\sigma_j^2 dt$. The CIR process is approximated by a gamma with mean and variance $\mu = r(t)e^{-\kappa dt} + \kappa (1 - e^{-\kappa dt})/\omega$ and $V = \beta^2 (1 - e^{-\kappa dt}) [2r(t)e^{-\kappa dt} + c(1 - e^{-\kappa dt})]/2\kappa$. This has the same mean and variance as the CIR evolution equation, but for non-instantaneous jumps, the gamma is a better approximation. The Vasicek priors are bivariate normals with correlation = ρ .

MCMC simulates the conditional distribution of the parameters given the data. For each simulated set of parameters, it simulates a value of each $r_j(t + dt)$ from the parameters and all the $r_j(t)$'s for the processes. Again this gives the conditional parameter distribution given the data. The different processes can end up with correlated parameters. Finally the fitted parameters and short rates are taken to be the means of the conditional distributions.

There are some model diagnostics. Each parameter has a convergence measure Rhat that will be close to 1.0 if the estimates have converged. We also check to see if the posterior distributions are pushing against the boundaries of the priors. If so, the priors are adjusted to accommodate. There are further diagnostics when parameters do not converge. Finally, loo can be used to compare alternative models.

A2a Estimation Using Ordinary Differential Equations - ODEs

For MCMC model estimation, the prior for $dr_2(t), r_3(t)$ given r(t) is bivariate normal. To get the moments for this, we expand the evolution matrices. This gives:

$$\mu_2(t)dt = [\kappa_{21}(\theta_1 - r_1(t)) + \kappa_{22}(\theta_2 - r_2(t)) + \kappa_{23}(\theta_3 - r_3(t))]dt$$
$$z_2(t)\sqrt{dt} = \sigma_{21}\sqrt{\beta_1 r_1(t)dt}\epsilon_1(t) + \sigma_{22}\sqrt{\alpha_2 dt} + \beta_2 r_1(t)dt}\epsilon_2(t) + \sigma_{23}\sqrt{\alpha_3 dt} + \beta_3 r_1(t)dt}\epsilon_3(t)$$

and:

$$\mu_3(t)dt = [\kappa_{31}(\theta_1 - r_1(t)) + \kappa_{32}(\theta_2 - r_2(t)) + \kappa_{33}(\theta_3 - r_3(t))]dt$$
$$z_3(t)\sqrt{dt} = \sigma_{31}\sqrt{\beta_1 r_1(t)dt}\epsilon_1(t) + \sigma_{32}\sqrt{\alpha_2 dt} + \beta_2 r_1(t)dt\epsilon_2(t) + \sigma_{33}\sqrt{\alpha_3 dt} + \beta_3 r_1(t)dt\epsilon_3(t)$$

Using $E[(X - EX)^2]$ for the variance shows that it is the expected value of the stochastic part squared. All the terms of that that are mixtures of different ϵ_j 's have mean zero. The expected squared of a mean-zero normal is its variance, so, for a short time period dt, we have:

$$Variance(dr_{2}(t)) = \sigma_{21}^{2}\beta_{1}r_{1}(t)dt + \sigma_{22}^{2}(\alpha_{2} + \beta_{2}r_{1}(t))dt + \sigma_{23}^{2}(\alpha_{3} + \beta_{3}r_{1}(t))dt$$
$$Variance(dr_{3}(t)) = \sigma_{31}^{2}\beta_{1}r_{1}(t)dt + \sigma_{32}^{2}(\alpha_{2} + \beta_{2}r_{1}(t))dt + \sigma_{33}^{2}(\alpha_{3} + \beta_{3}r_{1}(t))dt$$

These depend on $r_{(t)}$, the CIR process, but for an $A_1(3)$ model, the variances do not depend on the Vasicek processes.

We calculate the covariance using E[(X - EX)(Y - EY)]. This is the product of the two stochastic terms, and again any mixed products have mean zero. This gives the incremental covariance:

$$Cov(dr_2(t), dr_3(t)) = \sigma_{21}\sigma_{31}\beta_1r_1(t)dt + \sigma_{22}\sigma_{32}(\alpha_2 + \beta_2r_1(t))dt + \sigma_{23}\sigma_{33}(\alpha_3 + \beta_3r_1(t))dt$$

For the prior for the starting point of each process, we again assume that each one has the long-term distribution for the process. The mean for each is its θ_j , the reverting mean. The variances are the one-year variances (i.e., for dt = 1) divided by twice the speed of mean reversion κ_{jj} , where for this purpose, r_1 takes its mean value θ_1 . By convention, mean reversion is expressed in annual terms.

Stan has a solver for systems of differential equations. You write the system as a single function at the top of the code, in the functions section. It gives as output the vector of left-hand sides of the system – here the $d/d\tau$ terms. We need $C(\tau)$ and $D_j(\tau)$ functions for each maturity τ , but for a given set of parameters, these are fixed across the observation times. Thus the function takes as arguments the current values of: $\tau, \tilde{K}, \tilde{\Omega}, \Sigma, \beta 0_j, j = 1, 2, 3$. This does not require r(t). Then to solve the system, the differential-equation solver function is applied to the output of the differential equation function. For some reason, Stan's name for this solver is "integrate_ode_rk45."

Appendix 3 - Code

Stan and R code is up on the CAS GitHub site. A few comments are below.

Stan is run in R and other platforms. Some R code is needed for that, but most of the code is for the models in Stan. It is easy to have the R code open in RStudio, then run a few lines as needed. What is up is typical R code for our models. We are not Stan experts and just reuse and modify code from online examples. This is undoubtedly inelegant and probably inefficient. We are probably using vectors and matrices when arrays would be better, looping more than we need to, etc. But the code can give some idea about how to approach MCMC fitting for these models. There is some R code up, but most of the code is for rstan, the R implementation of Stan. The R code includes some variations for different models.

The introductory Stan file is for a single CIR process. The structure of a Stan file is to first read in variables already populated from the R space, then define all the variables to be used. That takes a fair amount of real estate in a Stan file, and is needed because it will be translated to C++ then compiled. We make the risk-neutral parameters the first ones to estimate, and the model begins with calculating the C and D functions. Then the real-world parameters are defined, and from these the processes at each point are estimated. In the CIR file that just uses the CIR evolution equation to define the prior for the CIR process at each time point, conditional on the previous point. The gamma distribution approximation is used for that. From all this, the fitted values are calculated, then the model for the data is just normal in these values. Finally the likelihoods are computed to pass to loo.

We also put up this model done by solving the differential equations, as an example of how to do that, although no one ever would as the equations have already been solved in closed form. To do it, you start with a new functions section above the data section, and define the system of differential equations there. We call that system AB_eq, as it solves for the A and B functions. These produce the C and D functions after the system has been solved. It is solved by the function integrate_ode_rk45. This takes as arguments the name of the system to be solved, starting values at $\tau = 0$ – here a vector of zeros, the values of the risk-neutral parameters, the precision wanted for the iteration, and some other arguments. The latter are not well documented and are required even though not used, so we put in some (obscure) values that we found in Stan examples, and it all seems to work well. The values of the parameters are strung out in a linear array to pass to the function, which then puts them back into vectors, etc. There is probably a simpler way to do that, but we got it working by doing it, so kept doing it that way. The intermediate W and h calculations for CIR are not needed here, as those are for solving the system in closed form. All the other parts of the code after getting the C and D functions are the same as in the closed-form case. For the three-factor models, the Vasicek formulas and the correlation adjustment are needed. There is code provided for the CVV+ essentially affine model with the δ and γ terms included, and for the 7k3b model. The correlation adjustment is not needed for the 7k3b model, since it solves for C and D numerically. The priors for it are what gave the fit above, but alternative priors are shown as comments. They gave an even better fit, but the priors are very narrow, and with much deviation from these ranges the model deteriorates rapidly. That makes them suspect as a fluke set of priors that works for the current data but is not really representative of a longer-term population, but both sets are worth trying. Probably for new data they would both have to be modified after seeing how they perform. The posterior histograms can help show if the parameters are trying to move in one direction or another from the priors used.

Some miscellaneous R code is shown below for defining the paras variable used in the print and plot statements, and for extracting the simulated samples for use in simulating future scenarios.

```
#for 7k3b model
paras <- c("kaprn", "kaprn21", "kaprn23", "kaprn31", "kaprn32", "omrn", "lb1", "lb2",</pre>
"lb3","ls2","ls3", "corr","kap", "kap21","kap23","kap31","kap32","om","ldel","gam1")
#for CVV plus model
paras <-
c("kaprn", "omrn", "lb", "ls2", "ls3", "sigma y", "corr", "kap", "om", "ldel", "gam1")
us1 ss = extract(us 1, permuted = FALSE) # this gets all the samples
#Need permuted = FALSE to get it in array form
dim(us1 ss) # shows dimensions, like 1000 x 4 x 2000 for 1000 sampling draws,
#4 chains and 2000 things computed
us1_ss = us1_ss[,,c(1:28,105,182,259:277,286:336)]
# keeps only variables that are needed for 7k3b;
#for simulation. Here 105, 182, 259 were the last (90th) period's r values
#these numbers would change with more periods fit; also taus (278-285) left out
#careful though as arrays show in different order than in print output
#just keeping 1 chain will keep variables names to check: us1_ss = us_1_ss[,1,]
dim(us1 ss) = c(4000, 100) \# collapses first two dimensions (samples and chains)
write.csv(us1 ss, file="samples out.csv")
```

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